

Issue Classification

Application/Control No.

10662532

Applicant(s)/Patent Under Reexamination

KOIDE ET AL.

Examiner

Nano, Sargon N

Art Unit

2157

ORIGINAL

CLASS

SUBCLASS

709

223

INTERNATIONAL CLASSIFICATION

CLAIMED

NON-CLAIMED

G 0 6 F

15 / 173 (2006.01.01)

G 0 6 F

15 / 16 (2006.01.01)

CROSS REFERENCE(S)

CLASS

SUBCLASS (ONE SUBCLASS PER BLOCK)

709

203

204

218

223

Nano, Sargon N

8/3/2007

(Assistant Examiner)

(Date)

(Legal Instruments
Examiner)

(Date)

ADRIENNE
SUPERVISORY PATENT EXAMINER
TECHNOLOGY CENTER 2100

(Primary Examiner)

(Date)

8/3/07

Total Claims Allowed:

31

O.G. Print Claim(s)

1

O.G. Print Figure

29